


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541551	<b>Applicant(s)/Patent Under Reexamination</b>  MOTOI, TAIKO
	<b>Examiner</b>  Logie, Michael J	<b>Art Unit</b>  2809

SEARCHED			
Class	Subclass	Date	Examiner
250	306	10/16/2007	ml
250	307	10/16/2007	ml
250	311	10/16/2007	ml
250	442.11	10/16/2007	ml
250	443.1	10/16/2007	ml

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)--See search notes	10/17/2007	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner